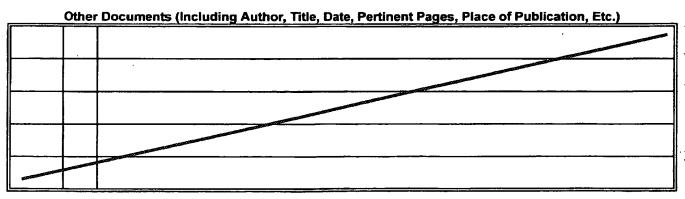
U.S. Patent Documents

Examiner Initial	Document Number	Date	Patentee/Applicant	Class	Subclass	Filing Date if Appropriate
				and the same of th		

Foreign Patent Documents

Examiner Initial	Document Number	Publication Date	Country/Agency	Class	Subclass	Translation	
muai						Yes	No
	2001-235606	08/31/01	Japan				
	2002-182017	06/26/02	Japan				
	2001-356207	12/25/01	Japan				
	00/34806	06/15/00	PCT				
	03/044572	05/30/03	PCT				

3/5/10



Examiner /Meghan Dunwiddie/ Date Considered 04/21/2008

EXAMPLER: Initial if citation is considered, whether or not citation is in conformance with MPEP 609; Draw a line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /M.D./